

SPECIFICATION

COMMERCIALY AVAILABLE

ITEM: DIELECTRIC CERAMIC FILTER

PART NUMBER: CF-16000504

Release Date: July 6, 2007

| ISSUED | CHECKED | CHECKED | CHECKED | APPROVED |
|--------|---------|---------|---------|----------|
| | | | | |

FILTRONETICS Inc

1. APPLICATION

THIS SPECIFICATION APPLIES TO A BAND PASS FILTER USING DIELECTRIC RESONATORS.

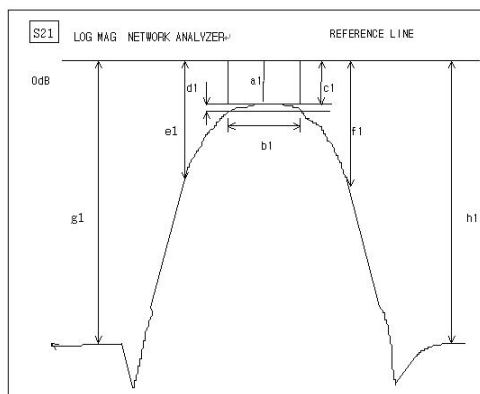
2. PART NUMBER

| | |
|-----------|--------------|
| PART NO | CF-16000504 |
| PACKAGING | PLASTIC TRAY |

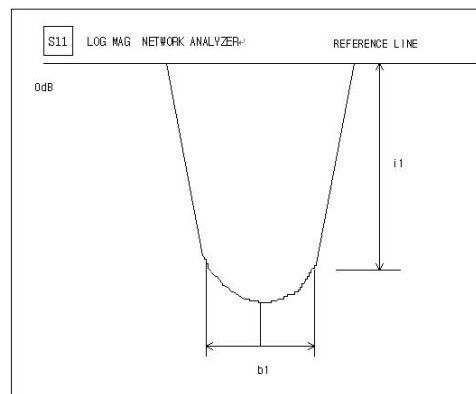
3. SPECIFICATIONS

| NO | ITEMS | Ref. | SPECIFICATION |
|----|-------------------------------------|-------------|---|
| 1 | Center Frequency (Fo) | a1 | 1600 MHz |
| 2 | 3.0dB Band Width | b1 | 50 MHz +/-10% |
| 3 | Insertion Loss AT Fo | a1 | 3.2 dB Max |
| 4 | V.S.W.R AT Fo+/-20MHz | - | 1.75:1 Min |
| 5 | Attenuation [absolute value] | At 1550 MHz | 23 dB Min |
| | | At 1650 MHz | 19 dB Min |
| 6 | Group Delay Variation AT Fo+/-20MHz | - | 30ns Max |
| 7 | Impedance | - | 50Ω |
| 8 | Maximum Input Power | - | 1 W (+30dBm) |
| 9 | Operating Temperature Range | - | -35 ~ +85°C |
| 10 | Workmanship | - | IPC-610 class 3 |
| 11 | Process Temperature | - | +150°C for 1 hour or +230°C for 10 minutes |

S21 LOG MAG NETWORK ANALYZER

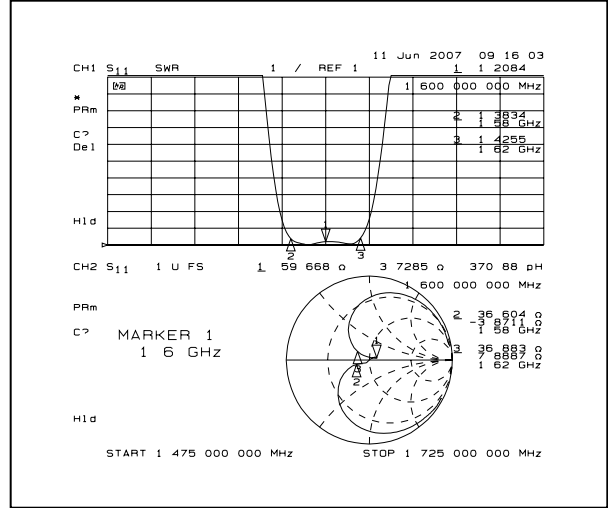
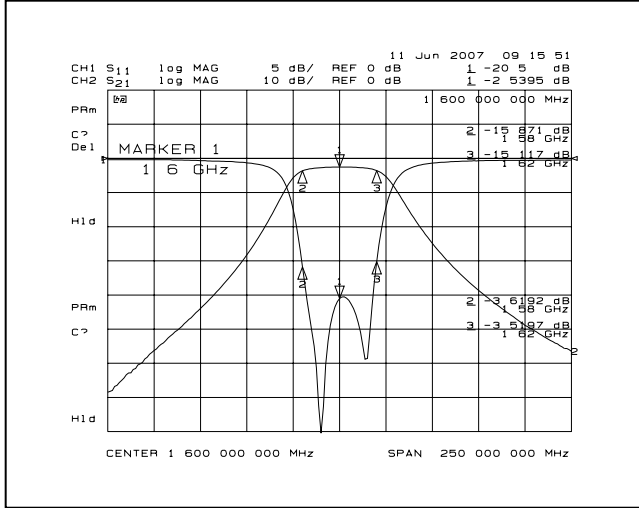


S11 LOG MAG NETWORK ANALYZER

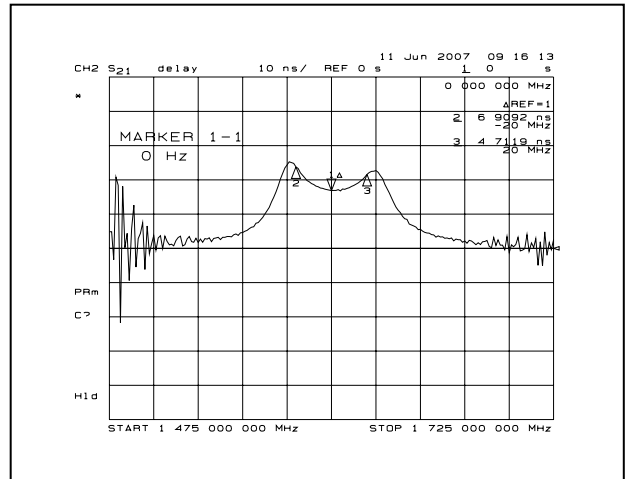
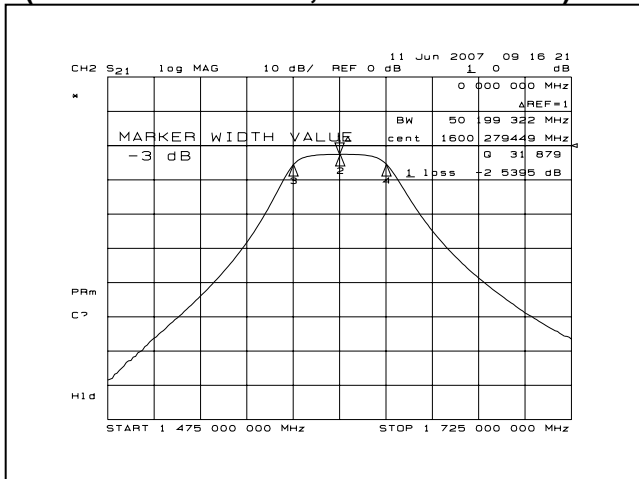


4. GRAPHS

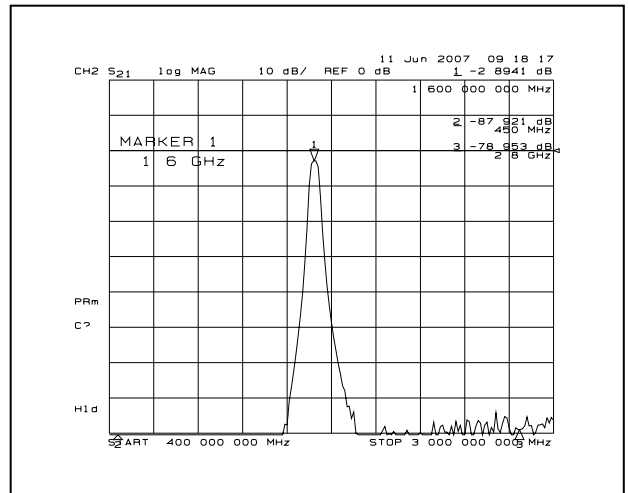
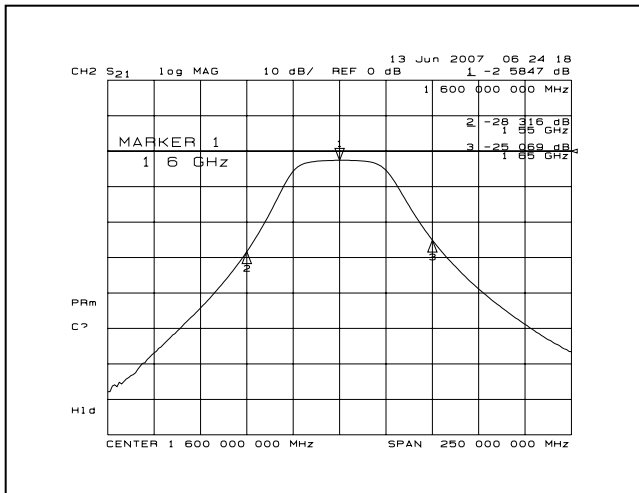
S21 vs. S11 (INSERTION LOSS, RETURN LOSS, V.S.W.R, SMITH CHART)



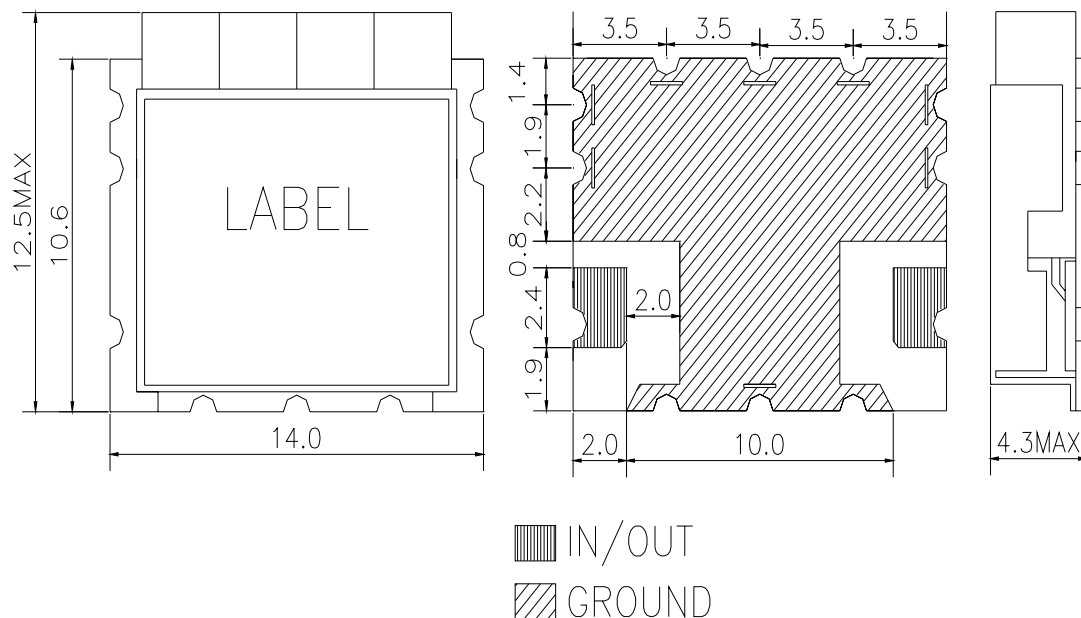
S21 (3dB BAND WIDTH, GROUP DELAY)



S21 (ATTENUATION, OUT BAND ATTENUATION)



5. DIMENSIONS



□ MATERIAL SPECIFICATION

1. PCB
 - 1) MATERIAL: FR4
 - 2) TERMINALS: Sn/Pb, HASL
2. METAL CASE
 - 1) Ag or Sn or Ni plated brass
3. RESONATOR
 - 1) COATING MATERIAL: silver plate, 8~30um
4. INTERNAL SOLDER
 - 1) Sn96.5/Ag3.5 Lead Free solder, 221 deg C melting
5. RESONATORS TABS
 - 1) Sn/Pb(9:1) Plated or Ag brass
6. NO PURE TIN ALLOWED

※ MARKING

Label Material: High temp polyimide

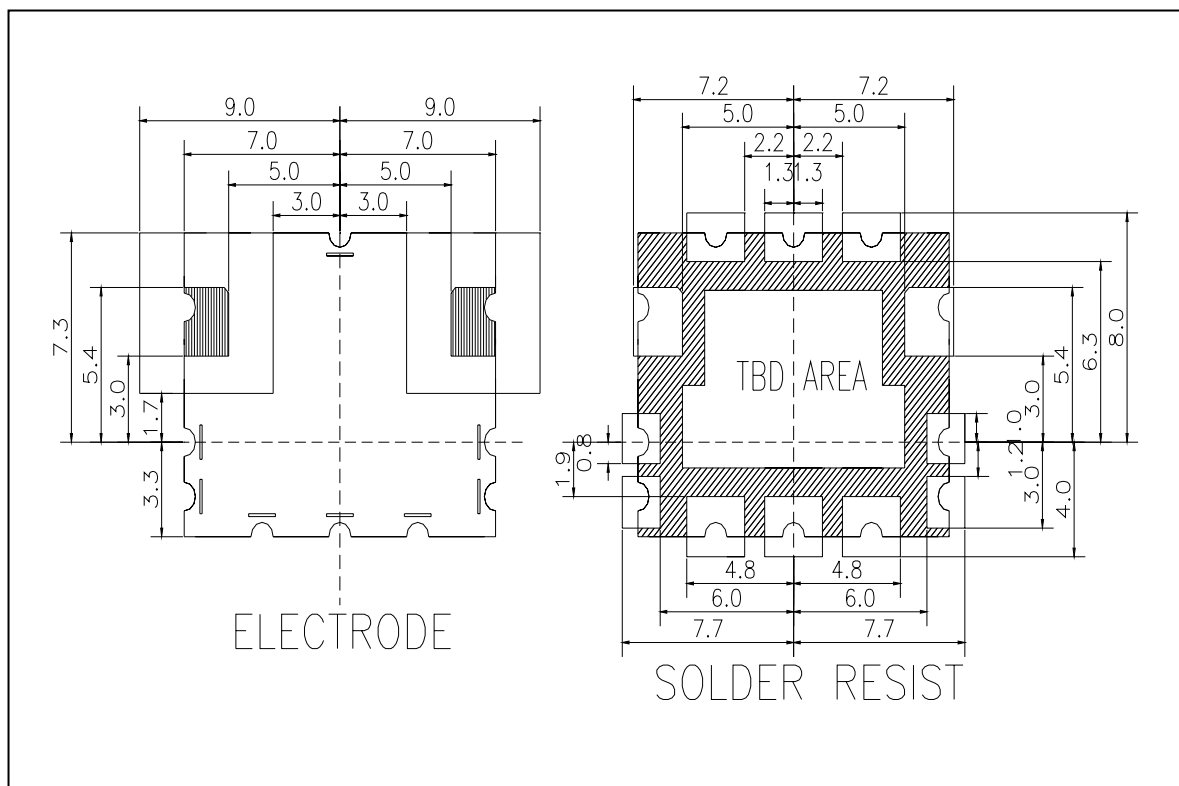
Marking:
CF-16000504
Filtronetics
Date Code

UNIT: MM
TOLERANCE: +/-0.5MM
IN/OUT LAND: +/-0.3MM

● CAUTIONS:

1. When handling products, be careful not to damage the outer-electrode.
2. When handling these products be careful not to touch the outer-electrode with bare hands or solder-ability is reduced.
3. Do not apply excessive pressure or shock to product in handling or in transportation or damage to the ceramic filters may result.

Recommended Solder Pattern:

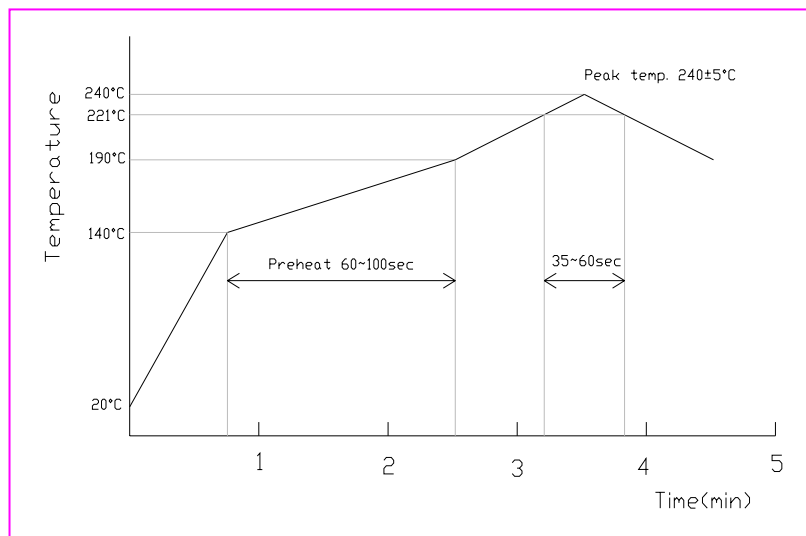


| Quality Conformance Test 100% Final inspection 100% Test Data *** | |
|--|---|
| 1) | Visual mechanical to IPC-610 Class 3 Including inspection for cleanliness. |
| 2) | Thermal Shock -44 to +85°C 10 cycles |
| 3) | Electrical Specifications at ambient |

6. DEFINITIONS

| TERMS | DESCRIPTION | SPECIFICATION |
|----------------------|--|------------------|
| Center Frequency | The midpoint of through band pass filter pass band, normally expressed as the arithmetic mean of the -3dB point. Also called Fo. | 3. SPECIFICATION |
| Pass Band Width | The width of the pass band of a filter referenced to the minimum insertion loss point in the pass band. The pass band of a filter is stated as -1.0dB bandwidth. | |
| Insertion Loss | The loss of the filter, in dB, measured at center frequency relative to a through line (0 dB). | |
| Attenuation | Reduction of RF power through a filter measured in dB, at desired band and referenced to 0 dB. (Filter to be removed from circuit) | |
| Pass Band Ripple | Variations in loss in the pass band of the filter, superimposed upon the fundamental shape of the pass band. | |
| V.S.W.R in Pass Band | The ratio of the maximum value of a standing wave to its minimum value, related to the return loss in pass band. | |

7. REFLOW SOLDERING STANDARD CONDITIONS



- Measuring point of temperature in-out terminals of the device.
- Reflow Soldering
- Both convection and infrared rays
- Hot air
- Solder Cream: Sn96.5/Ag3.5

8. RELIABILITY TEST AND CONDITIONS

| ITEM | TEST CONDITIONS | REQUIREMENTS |
|---|--|--|
| Resistance to solder heat | Preheat temperature : 120 to 150°C Preheat time: 1 to 1.5 min Solder temperature: 260 +/- 10°C Dipping time: 10 +/- 0.5 sec →Soldering Time : 5sec.max.per each terminal | No damage such as cracks should be caused in chip element. |
| Solderability | Preheat temperature: 120 to 150°C Preheat time: 1 to 1.5 min Solder temperature: 235 +/- 5°C Dipping time: 5 +/- 1 sec | More than 80% of the terminal electrode shall be covered with new solder |
| Heat resistance (High-temperature Load) | Temperature: 85 +/- 2°C Applied voltage: Rated voltage Applied current: Rated current Recovery: 1 to 2hrs of recovery under the standard condition after the removal from test chamber. | No mechanical damage. After test, the device shall satisfy the specification in section 3. Standard condition is 25+/-5°C and Less than 65% relative humidity |
| Thermal shock (Temperature cycle) | Conditions for 1 cycle Step 1: + 85°C 15 min Step 2 : - 44°C 15 min Number of cycle: 10 | No mechanical damage. After test, the device shall satisfy the specification in section 3. |
| Humidity Resistance | Temperature: 40 +/- 2°C Humidity: 90 to 95% RH Duration: 96 +/- 5 hrs Recovery: 1 to 2hrs of recovery under the standard condition after the removal from test chamber. | No mechanical damage. After test, the device shall satisfy the specification in section 3. |
| Vibration | The device is subjected to vibration of 2 sweeps in each of three mutually perpendicular planes Frequency shall be varied within 10~50Hz with 1.5mm double amplitude and within 50~500 Hz With 10G's acceleration. Sweep time of Frequency Shall be 15minutes | No mechanical damage. After test, the device shall satisfy the specification in section 3. |
| Shock | The device is subjected to 3 shocks in each direction of six mutually perpendicular planes Each shock shall be a half-sine wave shaped with a magnitude of 30G's and a duration of 11msec. | No mechanical damage. After test, the device shall satisfy the specification in section 3. |